

<b>Notice of References Cited</b>	Application/Control No. 10/088,407	Applicant(s)/Patent Under Reexamination GRUTKE ET AL.	
	Examiner Katarzyna Wyrozebski Lee	Art Unit 1714	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,395,386	05-2002	Bagrodia et al.	428/323
	C	US-6,018,004	01-2000	Warzelhan et al.	525/440
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	K	US-			
	L	US-			
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#### NON-PATENT DOCUMENTS

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